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Bib Data Sheet

SERIAL NUMBER 10/632,273	FILING DATE 07/31/2003 RULE	CLASS 324	GROUP ART UNIT 2829	ATTORNEY DOCKET NO. MI22- 2379
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APPLICANTS

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** CONTINUING DATA *****

This application is a DIV of 10/057,711 01/24/2002 PAT 6,670,819
 which is a DIV of 09/411,139 10/01/1999 PAT 6,657,450
 which is a DIV of 09/267,990 03/12/1999 PAT 6,380,754
 which is a DIV of 08/895,764 07/17/1997 PAT 6,127,195
 which is a CON of 08/621,157 03/21/1996 ABN
 which is a CON of 08/206,747 03/04/1994 PAT 5,523,697
 which is a DIV of 08/116,394 09/03/1993 PAT 5,326,428

checked at

** FOREIGN APPLICATIONS *****

None

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 10/28/2003

Foreign Priority claimed	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no	STATE OR COUNTRY ID	SHEETS DRAWING 10	TOTAL CLAIMS 11/28	INDEPENDENT CLAIMS 1/10
35 USC 119 (a-d) conditions met	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after				
Verified and Acknowledged	<i>Alvarenga</i> Examiner's Signature	Initials			

ADDRESS

021567
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TITLE

Method and apparatus for testing semiconductor circuitry for operability and method of forming apparatus for testing semiconductor circuitry for operability

 All Fees

FILING FEE
RECEIVED
2526

FEES: Authority has been given in Paper
No. _____ to charge/credit DEPOSIT ACCOUNT
No. _____ for following:

- 1.16 Fees (Filing)
- 1.17 Fees (Processing Ext. of time)
- 1.18 Fees (Issue)
- Other _____
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